

## Supporting Information

### Design of a Nitridoalumosilicate Red Phosphor Synthesized Under Mild Conditions

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## Experiment section

### Materials synthesis

A series of  $\text{Ca}_{4-4x}\text{SiAl}_3\text{N}_7: x\text{Eu}^{2+}$  ( $0 \leq x \leq 0.005$ ) samples were synthesized through sample-pressure sintering. Appropriate amounts of  $\text{Ca}_3\text{N}_2$  (Aldrich, >95.0%),  $\text{AlN}$  (Aldrich, >98.0%),  $\text{Si}_3\text{N}_4$  (Aldrich, 99.5%) and  $\text{EuCl}_3$  (>99.999%, Aladdin) were weighted and ground in a nitrogen-filled glovebox. The mixture was compressed into an alumina crucible, and then placed into a horizontal tube furnace and annealed at 1350 °C in a  $\text{N}_2$  atmosphere for four hours. Finally, the furnace-cooled samples were ground into powder for further measurements.

### Measurements and characterizations

The phases of  $\text{Ca}_{4-4x}\text{SiAl}_3\text{N}_7: x\text{Eu}^{2+}$  ( $0 \leq x \leq 0.005$ ) were identified by powder X-ray diffraction (PXRD) through a PANalytical X'Pert powder X-ray diffractometer. The Rietveld refinement was carried out using the GSAS program. The morphology of the powder was recorded by a SEM (S-3400, Hitachi, Japan).

The photoluminescence (PL), photoluminescence excitation (PLE) spectra, decay curves, temperature-dependent PL spectra and time-resolved PL (TRPL) spectra of the samples were measured by a FS5 fluorescence spectrometer. The TRPL spectra are constructed by slicing a series of decay curves of the sample obtained by monitoring a continuous wavelength range (500-500 nm, interval of 5 nm). The diffusion reflectance

spectroscopy (DRS) of Eu<sup>2+</sup>-doped and un-doped Ca<sub>4</sub>SiAl<sub>3</sub>N<sub>7</sub> were measured by a Shimadzu UV-2700 spectrophotometer.

The WLEDs were packaged by a SH2012 ultrasonic wire welding machine. The optical performances of the WLEDs were evaluated using a PMS-80 UV-vis-near IR spectrophotometer.

The bandgap is calculated by the following equations:

$$(\alpha hv)^n = A(hv - E_g) \quad (1)$$

$$\alpha = \frac{(1 - R)^2}{2R} \quad (2)$$

Where  $\alpha$  is the absorption coefficient,  $hv$  is the incident photo energy,  $A$  is a constant, and  $n = 1/2$  for indirect bandgap.

The decay curve is well fitted by a two exponential function, which can be expressed by the following equation:

$$I = A_1 \exp^{(-t/\tau_1)} + A_2 \exp^{(-t/\tau_2)} \quad (3)$$

where  $I$  is the emission intensity,  $t$  is the time,  $A_1$  and  $A_2$  are the fitted constants,  $\tau_1$  and  $\tau_2$  are the lifetime. Thus, the average decay time can be calculated via the following formula:

$$\tau = \frac{(A_1 \tau_1^2 + A_2 \tau_2^2)}{(A_1 \tau_1 + A_2 \tau_2)} \quad (4)$$

The thermal quenching activation energy ( $\Delta E$ ) of the sample was calculated through the Arrhenius equation:<sup>22</sup>

$$I(T) = I_0/[1 + A \exp(-\Delta E/kT)] \quad (5)$$

Where  $T$  represents temperature,  $I(T)$  is the emission intensity of the sample at temperature  $T$ ,  $I_0$  is the initial emission intensity,  $A$  is the ordinary constant, and  $K$  is the Boltzmann constant.

The critical distance ( $R_c$ ) for Eu<sup>2+</sup> quenching in Ca<sub>4</sub>SiAl<sub>3</sub>N<sub>7</sub> was calculated based on the following formula :

$$R_c = 2 \left[ \frac{3V}{4\pi N x_c} \right]^{\frac{1}{3}} \quad (6)$$

where  $x_c$  is the optimal  $\text{Eu}^{2+}$  doping concentration,  $V$  is the unit cell volume, and  $N$  is the number of  $\text{Ca}^{2+}$  atoms in a single unit cell.

Table S1 Crystal structure information of several silicon-based nitrides

Phase	Si/ (Al+Si )	Smallest structural unit	Basic structural unit	Connection type	Ref.
$\text{Sr}_2\text{Si}_5\text{N}_8$	1	$\text{SiN}_4$	$\text{Si}_6\text{N}_{18}$ six-membered ring	common angle, common edge	[23]
$\text{CaSiN}_2$	1	$\text{SiN}_4$	$\text{Si}_6\text{N}_{18}$ six-membered ring	common angle, common edge	[24]
$\text{Ba}_2\text{AlSi}_5\text{N}_9$	5/6	$\text{SiN}_4$ , $\text{AlN}_4$	$\text{Si}(\text{Al})_6\text{N}_{18}$ six-membered ring	common angle, common edge	[25]
$\text{SrAlSi}_4\text{N}_7$	4/5	$\text{SiN}_4$ , $\text{AlN}_4$	$\text{Si}_6\text{AlN}_{21}$ seven-membered ring	$\text{AlN}_4$ -common edge, $\text{SiN}_4$ -common angle	[26]
$\text{CaAlSiN}_3$	1/2	$\text{SiN}_4$ , $\text{AlN}_4$	$\text{Si}(\text{Al})_6\text{N}_{18}$ six-membered ring	common angle	[19]
$\text{Ca}_5\text{Si}_2\text{Al}_2\text{N}_8$	1/2	$\text{SiN}_4$ , $\text{AlN}_4$	$\text{Al}_6\text{N}_{18}$ six-membered ring	$\text{AlN}_4$ - common angle, common edge, $\text{SiN}_4$ - common edge	[27]
$\text{Ca}_4\text{SiAl}_3\text{N}_7$	1/4	$\text{SiN}_4$ , $\text{AlN}_4$	$\text{Al}_4\text{SiN}_{15}$ five-membered ring	$\text{AlN}_4$ - common angle, common edge, $\text{SiN}_4$ - common edge	This work

Table S2 crystallographic data of  $\text{Ca}_4\text{SiAl}_3\text{N}_7$

Formula sum:  $\text{Ca}_4\text{SiAl}_3\text{N}_7$

Formula weight: 1101.06 g/mol

Crystal system: triclinic

Space-group: P -1 (2)

Cell parameters:  $a=5.8778 \text{ \AA}$ ,  $b=8.1422 \text{ \AA}$ ,  $c=13.0503 \text{ \AA}$ ,  $\alpha=78.2130^\circ$ ,  $\beta=76.8350^\circ$ ,  $\gamma=82.3320^\circ$ ,

Cell ratio:  $a/b=0.7219$   $b/c=0.6239$   $c/a=2.2203$

Cell volume:  $592.85 \text{ \AA}^3$

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Calc. density: 3.08385 g/cm<sup>3</sup>

Formula type: N<sub>2</sub>O<sub>10</sub>P<sub>12</sub>Q<sub>21</sub>

Wyckoff sequence: i22a

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Table S3 Atomic parameters of Ca<sub>4</sub>SiAl<sub>3</sub>N<sub>7</sub>

Atom	Wyck.	x/a	y/b	z/c
Ca1	2i	0.0949	0.0433	0.6526
Ca2	2i	0.1163	0.2899	0.9860
Ca3	2i	0.2950	0.4018	0.4618
Ca4	2i	0.5011	0.2567	0.7110
Ca5	2i	0.6021	0.0664	0.0976
Ca6	2i	0.7594	0.3465	0.2192
Si1	2i	0.1191	0.9249	0.1246
Al1	2i	0.0050	0.5976	0.3023
Al2	2i	0.1797	0.7246	0.5312
Al3	2i	0.2508	0.2268	0.2574
Al4	2i	0.3939	0.5721	0.0854
Al5	2i	0.3990	0.0638	0.4183
N1	2i	0.0960	0.2164	0.7917
N2	2i	0.1016	0.1681	0.4041
N3	2i	0.1166	0.6800	0.4044
N4	2i	0.1295	0.1217	0.1722
N5	2i	0.2399	0.4615	0.2229
N6	2i	0.2638	0.5208	0.6263
N7	2i	0.4182	0.8042	0.0940
N8	2i	0.5419	0.1111	0.2769
N9	2i	0.5474	0.1559	0.5092
N10	2i	0.7052	0.4473	0.0425
N11	1a	0	0	0

Table S4 The bond length data of Ca-N bond

type	bond length (Å)	type	bond length (Å)	type	bond length (Å)
Ca1-N1	2.517(2)	Ca2-N1	2.735(1)	Ca3-N2	2.652(4)
Ca1-N2	2.507(3)	Ca2-N4	2.545(3)	Ca3-N3	2.413(2)
Ca1-N3	2.483(5)	Ca2-N7	2.749(3)	Ca3-N3	2.728(4)
Ca1-N4	2.573(4)	Ca2-N10	2.432(2)	Ca3-N6	2.494 (1)
Ca1-N8	2.564(1)	Ca2-N10	2.595(5)	Ca3-N6	2.688 (2)
Ca1-N9	3.016(2)	Ca2-N11	2.504(5)	Ca3-N9	2.390 (3)
Ca4-N1	2.411(2)	Ca5-N1	3.017(6)	Ca6-N4	2.864(5)
Ca4-N3	2.456(5)	Ca5-N4	2.735(4)	Ca6-N5	3.065(5)
Ca4-N6	2.593(5)	Ca5-N7	2.530(4)	Ca6-N5	3.097(6)
Ca4-N7	2.636(3)	Ca5-N7	2.550(4)	Ca6-N6	2.445(3)
Ca4-N8	2.999(1)	Ca5-N8	2.381(2)	Ca6-N8	2.345(4)
Ca4-N9	2.860(1)	Ca5-N11	2.443(3)	Ca6-N10	2.363(4)
Average	2.617				

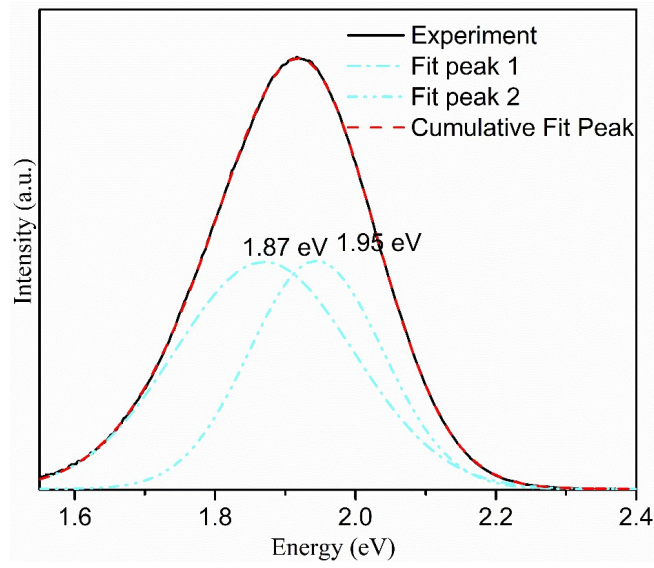


Fig. S1 Gauss Fit of the emission of  $\text{Ca}_4\text{SiAl}_3\text{N}_7:\text{Eu}^{2+}$ .

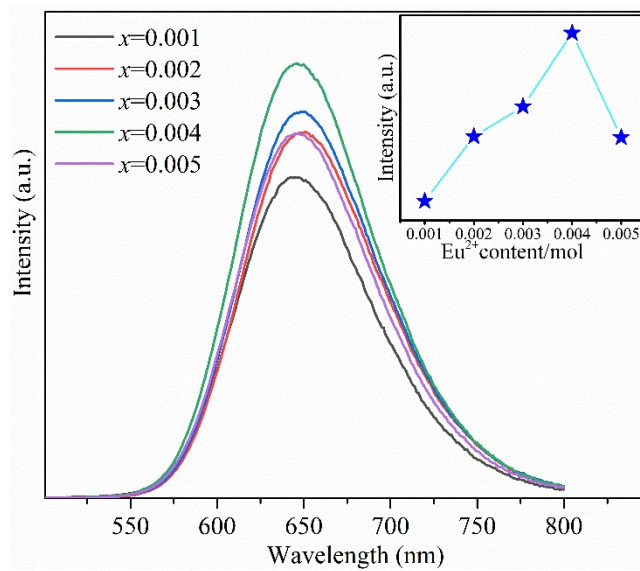


Fig. S2 Emission spectra of  $\text{Ca}_{4-4x}\text{SiAl}_3\text{N}_7: x\text{Eu}^{2+}$  ( $0 \leq x \leq 0.005$ ).

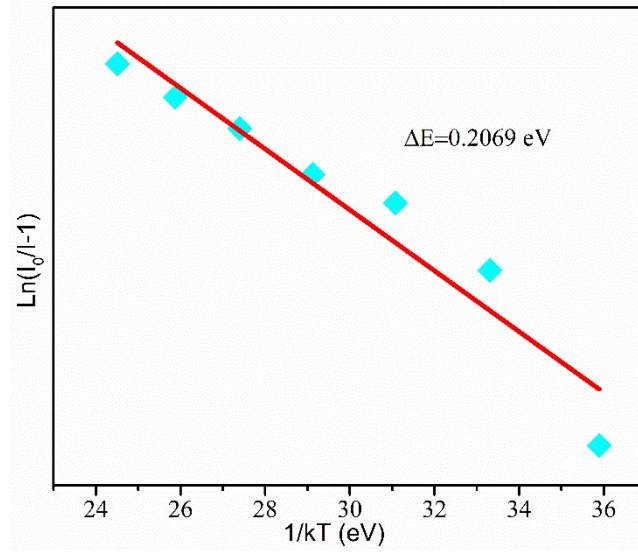


Fig. S3 Relationship between  $\ln(I_0/I-1)$  and  $1/KT$ .

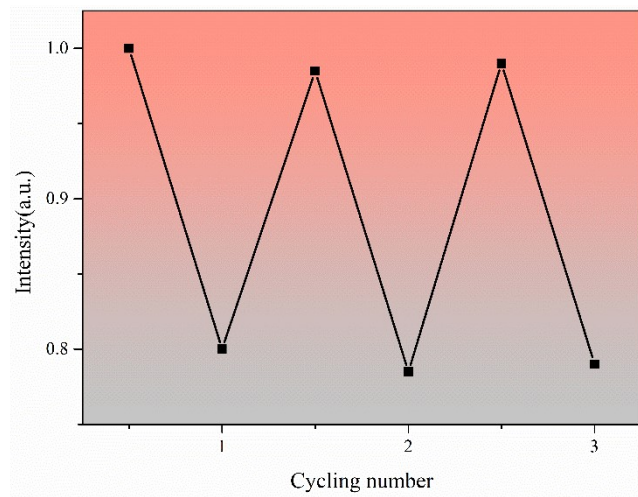


Fig. S4 Dependent of emission intensity on thermal quenching cycle between 298 and 473 K.